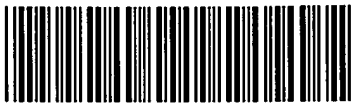


**Search Notes**

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Examiner

Alvin C. Chin-Shue

Applicant(s)/Patent under  
Reexamination

MEEKER, PAUL K.

Art Unit

3634

**SEARCHED**

Class	Subclass	Date	Examiner
<i>update</i>		<i>83.05</i>	<i>As</i>

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR